

Search Notes



Application/Control No.

09/883,178

Examiner

Mark K. Han

Applicant(s)/Patent under
Reexamination

NAIMARK ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	5.01	5/12/2006	mlh
	6.09		
	27		
	29		
	35		
	43		
	44		
	48		
	93.01		
	181		
	187		
	190		
	264		
	272		
	523		
	890.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor name search	6/27/2005	mlh
EAST text search	5/12/2006	mlh